


<b>Search Notes</b>  	<b>Application/Control No.</b>  10518182	<b>Applicant(s)/Patent Under Reexamination</b>  ROUTLEY ET AL.
	<b>Examiner</b>  Mandeville, Jason M	<b>Art Unit</b>  2609

SEARCHED			
Class	Subclass	Date	Examiner
345	30, 36, 39, 44-46, 55, 76-83, 204-207, 211-212, 214-215, 690, 697	19 April 2007	Jason Mandeville
345	30, 36, 39, 44-46, 55, 76-83, 204-207, 211-212, 214-215, 690, 697	12/17/2007	Jason Mandeville
345	30, 36, 39, 44-46, 55, 76-83, 204-207, 211-212, 214-215, 690, 697	06 August 2008	Jason Mandeville
345	30, 36, 39, 44-46, 55, 76-83, 204-207, 211-212, 214-215, 690, 697	09 March 2009	Jason Mandeville
345	30, 36, 39, 44-46, 55, 76-83, 204-207, 211-212, 214-215, 690, 697	11/09/2009	Jason Mandeville

SEARCH NOTES		
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Searched US-PGPUB, USPAT, USOCR, FPRS, EPO, JPO, DERWENT, IBM_TDB	19 April 2007	Jason Mandeville
Searched US-PGPUB, USPAT, USOCR, FPRS, EPO, JPO, DERWENT, IBM_TDB	12/17/2007	Jason Mandeville
Inventor Search	12/17/2007	Jason Mandeville
Searched US-PGPUB, USPAT, USOCR, FPRS, EPO, JPO, DERWENT, IBM_TDB	06 August 2008	Jason Mandeville
Inventor Search	06 August 2008	Jason Mandeville
Searched US-PGPUB, USPAT, USOCR, FPRS, EPO, JPO, DERWENT, IBM_TDB	09 March 2009	Jason Mandeville
Inventor Search	09 March 2009	Jason Mandeville
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Inventor Search	11/09/2009	Jason Mandeville

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
/J. M. M./ Examiner.Art Unit 2629			

<b>INTERFERENCE SEARCH</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>

/J. M. M./ Examiner,Art Unit 2629	
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